

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/688,745	MEYER ET AL.	
Examiner	Art Unit	_
Christian L. Fronda	1652	

SEARCHED					
Class	Subclass	Date	Examiner		
435	183, 193, 232, 320.1, 410	2/13/6C	coo		
536	23.2				
800	278,295	$\downarrow \downarrow$	1		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
STIC search SEQ ID NOs: 5, 30, 60, and 65-67	2/13/06	c17	
STN search notes attached to file	2/13/06	cM	
WEST search notes attached to file	2/13/06	cjj	